

## SPECIFICATION AND PERFORMANCE

Series 104	4H-TDA0-R01	File	104H-TDA0-R01_SPCE_2	Date	2017/10/26
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## Scope:

This specification covers the requirements for product performance, test methods and quality assurance provisions of **104H-TDAO-RO1** 

## **Performance and Descriptions:**

The product is designed to meet the electrical, mechanical and environmental performance requirements specification. Unless otherwise specified, all tests are performed at ambient environmental conditions.

## **RoHS**:

All material in according with the RoHS environment related substances list controlled.

MATERIAL AND FINISH			
INSULATOR	Material	Plastic Body : Liquid Crystal Polymer Slider : Liquid Crystal Polymer	
CONTACT	Material	Contact : Phosphor Bronze Alloy Switch : Phosphor Bronze Alloy	
CONTACT	Plating	Contact Area : 10u" Gold Plating Solder Area : Gold Flash	
SHELL OR COVER	Material	Shell : Stainless Latch : Stainless Drag Link : Stainless Spring : Piano Wire	
	Plating		
RATING	Rating Current: 0.5A (Max.)/(1PIN) Rating Voltage: 100V AC/DC Operating Temperature: $-40^{\circ}$ to $+90^{\circ}$ Storage Temperature: $-40^{\circ}$ to $+90^{\circ}$		

ELECTRICAL			
Item Requirement		Test Condition	
Contact Resistance	Initial: 80 mΩ Max	Solder connectors on PCB and mate them together, measure by applying closed circuit current of 10mA maximum at open circuit voltage of 20mV (max).(JIS C5402 5.4)	
Insulation Resistance	Initial: 1000MΩ Min	Apply 500V DC between adjacent contacts, or contact and ground. (MIL-STD-202 METHOD 302)	

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Dielectric Withstanding Voltage	Mate connectors; apply 500V AC (rms.) between two adjacent for 1 minute. (Trip current:1mA) (MIL-STD-202 METHOD 301)
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MECHANICAL			
Item	Requirement	Test Condition	
Contact Retention Force	2.5N per pin (Min.)	Place a connector on the push-pull machine, then apply a force on a contact head and push the contact to the opposite direction of the contact insertion at the speed of $25 \pm 3$ mm/min. (EIA364-29)	
Durability	No Damage Contact Resistance: 100mΩ(Max)	Solder connectors on PCB, then place them on the pull-push machine, and repeat mating and un-mating 10,000cycles repeatedly at a rate of 400~600 cycles/hour. (EIA364-09)	
Vibration	No electrical discontinuity more than 0.1µs. Contact Resistance: 100mΩ(Max)	Mate dummy card and subject to the following vibration conditions, for a period of 30 minutes in each of 3 mutually perpendicular axis, passing DC 1 mA during the test. Amplitude: 1.52 mm P-P or 19.6 m/s2 Frequency: 10-55-10Hz Shall be traversed in 1minute. (MIL-STD-202 METHOD 201)	
Shock	No electrical discontinuity more than 0.1µs. Contact Resistance: 100mΩ(Max)	Solder connectors on PCB and mate them together, subject to he following shock conditions, 3 shocks shall be period along 3 mutually perpendicular axis, passing DC 1mA current during the test. 1 axis, plus-minus direction, core 3times.(total:18times) 490m/s2 (MIL-STD-202 METHOD 213)	
Card Insertion / Eject Force	9.8N Max	Push the card at the speed rate $25 \pm 3$ mm/minute.	
Card Release Force	6N~9N	From the state of the card lock, Pull the card at the speed rate $25 \pm 3$ mm/minute.	
Push in strength	No Damage	The card inserted in positive and the opposite direction and the load of 30N is added	



	ENVIRON	NMENTAL
Item	Requirement	Test Condition
Temperature Cycle	Contact Resistance: 100m $\Omega$ (Max) Insulation Resistance: 100M $\Omega$ (Min)	Stage       Temp       Time $t1$ $-55^{\circ}$ C       30 min $t2$ $-55 \sim +90^{\circ}$ C       3 min $t3$ $+90^{\circ}$ C       30 min $t4$ $+90 \sim -55^{\circ}$ C       3 min
		Test time: 6 cycles $t^3$ $t^2$ $t^4$ (JIS C0025)
Heat Resistance	Contact Resistance: 100mΩ(Max) Insulation Resistance: 100MΩ(Min)	Solder connectors on PCB and mate them together, expose to 90 ± 20C for 96hrs. Upon completion of the exposure period, the test specimens shall be conditioned at ambient room conditions for 1 of 2hrs, after which the specified measurements shall be performed. (MIL-STD-202 METHOD 108)
Cold Resistance	Contact Resistance: 100mΩ(Max) Insulation Resistance: 100MΩ(Min)	Solder connectors on PCB and mate them together, expose to $-55 \pm 30$ C for 96hrs. Upon completion of the exposure period, the test specimens shall be conditioned at ambient room conditions for 1 of 2hrs, after which the specified measurements shall be performed. (EIA364-59)
Humidity	Contact Resistance: 100mΩ(Max) Insulation Resistance: 100MΩ(Min)	Humidity storage at +40°C with 90~95% RH for 96 hours. Upon completion of the exposure period,the test specimens shall be conditions for 1 of 2 hrs, then 10 mating cycles while. (EIA364-31)
Salt Spray	Contact Resistance: 100mΩ(Max)	$5 \pm 1\%$ salt solutions, at $35 \pm 2°C$ duration 48 hours. Connectors detached (MIL-STD-1344)

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		SOLDER A	BILITY
	Item	Requirement	Test Condition
Solder at	bility	95%of immersed area must show no voids , pin holes.	Dip solder tails into the molten solder(held at $230\pm5^{\circ}$ ) up to 0.5mm from the tip of tails for $3\pm0.5$ seconds. (MIL-STD-202 METHOD 208)
Resistand soldering		No melting, cracks or functional damage allowed	All connectors designed for PCB soldering within this specification must be able to withstand the heat from solder oven according to the graph below. The cycle should be repeated twice. (MIL-STD-202 METHOD 210)
Soldering Preheatir	perature: 260℃ 5 temperature: 23 ng temperature: 1 erature (℃)	0°C	-Peak temperature
230			
150		60-90 sec	20-30 sec
		Preheating	Soldering
			Time (sec)